





Spectrophotometer (HSCD Series)

Brochure

Global Office of Lisun Electronics Inc.

http://www.Lisungroup.com

Lisun Group (Hong Kong) Limited

Add: Room 803, Chevalier House, 45-51 Chatham Road South, Tsim Sha Tsui, KL, HK

Tel: 00852-68852050 Fax: 00852-30785638

Email: SalesHK@Lisungroup.com

Lisun Electronics (Shanghai) Co., Ltd

Add: 113-114, No. 1 Building, Nanxiang Zhidi Industry Park, No. 1101, Huyi Road, Jiading

District, Shanghai, 201802, China

Tel: +86(21)5108 3341 Fax: +86(21)5108 3342

Email: SalesSH@Lisungroup.com

Lisun Electronics Inc. (USA)

Add: 445 S. Figueroa Street, Los Angeless, CA 90071, U.S.A.

Email: Sales@Lisungroup.com

Lisun China Factory

Add: NO. 37, Xiangyuan Road, Hangzhou City, Zhejiang Province, China

Tel: +86-189-1799-6096

Email: Engineering@Lisungroup.com

Leader in Lighting & Electrical Test Instruments

Rev. 10/18/2019

Spectrophotometer

product models



HSCD-680



HSCD-700



HSCD-710



HSCD-750

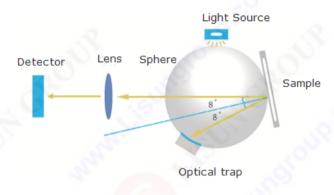


HSCD-760

Brief Introduction

 Our device adopts internationally agreed observe condition D/8 (Diffused lighting, 8 degrees observe angle) and SCI (specular reflection included)/SCE (specular reflection excluded).

It could be used for color matching for many industries and widely used in painting industry, textile industry, plastic industry, food industry, building material industry and other industries for quality control.



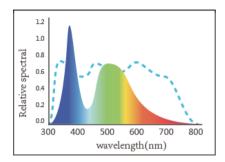
Camera view to catch the testing area

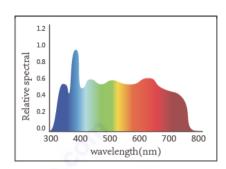
In previous measurement instrument, we can only aim at the testing area approximately, and this may cause errors. Our spectrophotometers include a camera in our optical system, and the user can clearly see the tested area to avoid measurement errors.



Uses CLEDs light source – spectrally balanced LED light source

LED light source that has balanced intensity across visible spectrum avoids the spectral deficiency in certain parts of the spectrum in common white LEDs, and guarantees the speed of the measurement and the accuracy of the results. This research finding has been published in national leading, SCI included optical journal, Chinese Optics Letter.





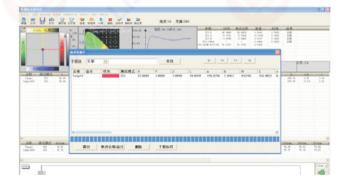
ETC Every Time calibration technology

Currently, most instruments use standard white boards for calibration. When white board is damaged, the instrument's accuracy or precision will no longer be guaranteed. In CHN Spec's spectrophotometers, it uses innovative ETC(Every Test Calibration); standard white board is included in the optical system, and therefore has reliable accuracy and repeatability in every measurement.



Matching color analysis software

Our spectrophotometer has the color management software, which is applicable in various industries' quality control and management of color data. It turns color into numerical data, compares color differences, generates measurement reports. provides measurement data under different color spaces and customizes color management for each customer.



Automatic gloss compensation technology

Different gloss, or different instrument's lighting or observation conditions will

largely affect the measurement of color. The automatic gloss compensation technology guarantees the accuracy of color measurement data for surfaces of different gloss. This research finding is published in international leading, SCI included journal, Optic.



Innovative light splitting SCS optical engine

Adopt innovative single-grating-double-beam light splitting system: SCS optical engine, creates the best measurement repeatability for portable spectrophotometers in the industry, and guaranteed accurate measurement of surface color of materials.



• The most complete and color indicators compares with similar instruments.

Comparing with similar products, our spectrophotometers offer the most complete, 28 kinds of standard light sources for lighting conditions and 40 measurement color value indicators; It can also customize measurement methods according to your requirement, and satisfy all your color measurement needs.

Technical Data

Туре	HSCD-680	HSCD-700	HSCD-710	HSCD-750	HSCD-760	
	Observation angle: 2°/10°					
	Illumination: d/8(Diffused lighting, 8 degrees observe angle)					
Measurement	SCI (specular reflection included)/SCE (specular reflection					
condition	excluded)simultaneous measurement (conform to CIE No.15、ISO 7724/1、ASTM E1164、DIN 5033 Teil7、 JIS Z8722 Condition c standards)					
Size of	Φ40mm,Avian diffused reflection surface coating					

	1					
Туре	HSCD-680	HSCD-700	HSCD-710	HSCD-750	HSCD-760	
integrating						
sphere				1	1	
				CLEDs		
Illumination	CLEDs/Full	band balance	Pulse	(Full band		
Light source	source)	barra bararro	Xenon	balanced		
2.9.11 33 4.1 33	30dice)			Lamp	LED light	
		,	- 0	source)		
Sensor	dual light path sensor array					
Wavelength	400-700nm			360-740n	400-700n	
Range				m	m	
Wavelength	10nm					
interval	V	~4· _A	70)	76.	Q	
Half spectral	5nm					
width	100		ν	⁶ 0.	-	
Reflectivity	0-200%					
range	-0)					
Reflectivity	0.01%					
resolution	A C DEO DE	T D/F D7F F	1 52 52 54 5	T F/ F7 F0 F	0 510 511	
Measurement	A,C,D50,D55,D65,D75,F1,F2,F3,F4,F5,F6,F7,F8,F9,F10,F11,					
	F12,DLF,TL83,TL84,NBF,U30,CWF SPD distribution/data, sample's color values, color difference					
light source				cyclus cold	or difference	
light source	SPD distribu	ution/data, s	ample's colo			
Data being	SPD distribution	ution/data,s h,pass/fail	ample's color results, colo	or error tend	lency, color	
1511	SPD distribution, simulation,	ution/data, s h, pass/fail display me	ample's color results, color asurement a	or error tend area, history	lency, color data color	
Data being	SPD distribution, simulation	ution/data, s h, pass/fail display me , manual i	ample's color results, color asurement a	or error tend	lency, color data color	
Data being	SPD distribution, simulation, measurement	ution/data, s h, pass/fail display me , manual i	ample's color results, color asurement a	or error tend area, history	lency, color data color	
Data being displayed	SPD distribution, simulation	ution/data, s h, pass/fail display me , manual i	ample's color results, color asurement a	or error tend area, history	lency, color data color	
Data being displayed Measurement	SPD distribution values/graph simulation, simulation measuremed 2 seconds	ution/data, s oh, pass/fail display me , manual i ent report	results, color results, color asurement a nput standa	or error tend area, history ard sample	lency, color data color , generate	
Data being displayed Measurement time interval	SPD distribution, simulation, measurement	ution/data, s oh, pass/fail display me , manual i ent report	ample's color results, color asurement a	or error tend area, history	lency, color data color	
Data being displayed Measurement time interval Measurement	SPD distribution values/graph simulation, simulation measuremed 2 seconds	ution/data, s oh, pass/fail display me , manual i ent report	results, color results, color asurement a nput standa	or error tend area, history ard sample	lency, color data color , generate	
Data being displayed Measurement time interval Measurement	SPD distribution values/graph simulation, simulation measuremed 2 seconds	ution/data, soh, pass/fail display me, manual ient report	results, color results, color asurement a nput standa	or error tend area, history ard sample	lency, color data color, generate	
Data being displayed Measurement time interval Measurement	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b	ution/data, soh, pass/fail display me, manual ient report	results, color results, color asurement a nput standa 5S L*C*h, L*u	or error tend area, history ard sample 2S	lency, color data color, generate 0.5S	
Data being displayed Measurement time interval Measurement time	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b, L*C*h,	ution/data, soh, pass/fail display me, manual ient report	results, color results, color asurement a nput standa 5S L*C*h, L*u	or error tend area, history ard sample	lency, color data color, generate 0.5S	
Data being displayed Measurement time interval Measurement time	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b, L*C*h, L*u*v,	ution/data, soh, pass/fail display me, manual ient report	results, color results, color asurement a nput standa 5S L*C*h, L*u	or error tend area, history ard sample 2S	lency, color data color, generate 0.5S	
Data being displayed Measurement time interval Measurement time	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b, L*C*h, L*u*v, XYZ, Yxy,	ution/data, soh, pass/fail display me, manual ient report	results, color results, color asurement a nput standa 5S L*C*h, L*u	or error tend area, history ard sample 2S	lency, color data color, generate 0.5S	
Data being displayed Measurement time interval Measurement time	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b, L*C*h, L*u*v, XYZ, Yxy, Reflective ΔE*ab, ΔE*CH,ΔE	ution/data, soh, pass/fail display me, manual ient report	results, color results, color asurement a nput standa 5S L*C*h, L*u	or error tend area, history ard sample 2S	lency, color data color, generate 0.5S	
Data being displayed Measurement time interval Measurement time Color space	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b , L*C*h, L*u*v, XYZ, Yxy, Reflective ΔE*ab, ΔE*CH,ΔE *uv,ΔE*c	ution/data, soh, pass/fail display me, manual ient report O. CIE-L*a*b, Hunterlab,	results, color results, color asurement a nput standa 5S L*C*h, L*u Munsell MI, (or error tend area, history ard sample 2S *v, XYZ, Yxy CMYK, RGB, H	lency, color data color, generate 0.5S Reflective, HSB	
Data being displayed Measurement time interval Measurement time Color space Color difference	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b, L*C*h, L*u*v, XYZ, Yxy, Reflective Δ E*ab, Δ E*CH, Δ E*uv, Δ E*c mc(2:1), Δ	ution/data, soh, pass/fail display me, manual interport CIE-L*a*b, Hunterlab,	results, color results, color asurement a nput standa	error tendorea, history and sample 2S *v, XYZ, Yxy CMYK, RGB, F	lency, color data color, generate 0.5S Reflective, HSB	
Data being displayed Measurement time interval Measurement time Color space	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b , L*C*h, L*u*v, XYZ, Yxy, Reflective ΔE*ab, ΔE*CH,ΔE *uv,ΔE*c mc(2:1),Δ E*cmc(1:	ution/data, soh, pass/fail display me, manual interport CIE-L*a*b, Hunterlab,	results, color results, color asurement a nput standa 5S L*C*h, L*u Munsell MI, (error tendorea, history and sample 2S *v, XYZ, Yxy CMYK, RGB, F	lency, color data color, generate 0.5S Reflective, HSB	
Data being displayed Measurement time interval Measurement time Color space Color difference	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b, L*C*h, L*u*v, XYZ, Yxy, Reflective	ution/data, soh, pass/fail display me, manual interport CIE-L*a*b, Hunterlab,	results, color results, color asurement a nput standa	error tendorea, history and sample 2S *v, XYZ, Yxy CMYK, RGB, F	lency, color data color, generate 0.5S Reflective, HSB	
Data being displayed Measurement time interval Measurement time Color space Color difference	SPD distribution values/graph simulation, simulation measuremed 2 seconds 2S CIE-L*a*b , L*C*h, L*u*v, XYZ, Yxy, Reflective ΔE*ab, ΔE*CH,ΔE *uv,ΔE*c mc(2:1),Δ E*cmc(1: 1),ΔE*94, ΔE*00	ution/data, soh, pass/fail display me, manual interport CIE-L*a*b, Hunterlab, ΔE*ab,ΔE*6 ,ΔE*94,ΔE*	results, color results, color asurement a nput standa 5S L*C*h, L*u Munsell MI, (CH,ΔE*uv,ΔE	error tendorea, history and sample 2S *v, XYZ, Yxy CMYK, RGB, F	lency, color data color, generate 0.5S Reflective, HSB	

Туре	HSCD-680	HSCD-700	HSCD-710	HSCD-750	HSCD-760	
colorimetric						
indices	Taube Berger, Ganz, Stensby); YI(ASTM D1925, ASTM					
indices	E313-00, ASTM E313-73): Tint(ASTM E313, CIE, Ganz)					
	Metamerism index Milm, Stick color fastness, Color fastness					
		ISO luminance, 8 gloss, A density, T density, M				
	density, E density					
	light splitting reflectivity: standard deviation within 0.08%					
	Color	color	76.			
	values:	values;	30			
	ΔE*ab<=	ΔE*ab<=	2		_	
	0.03(After	0.03(After			2/1	
	calibration	calibration				
~	, standard	, standard	500		Chromatic	
Donostobility	deviation	deviation of 30	color value	es: ΔE*ab	ity values: ΔE*ab<=	
Repeatability	of 30		<=0.02,Ma	ximum:0.0	100	
	measure ments on	measure ments on	4		0.015 Maximum	
	test white	test white	. 1.1		:0.03	
_	board, 5	board, 5	a.		:0.03	
	second	second	220		die	
ALC:	intervals),	intervals),			160	
100	Maximum	Maximum			,	
.60	:0.05	: 0.05				
Battery	.0.03	. 0.03	-0	100	<i>A</i> 0	
capacity	rechargeabl	e, 10000 cor	ntinuous test	s, 7.4V/6000	mAh	
Interface	USB	0			0	
Data storage		regults	710			
Light source	20000 test results					
longevity	5 years, 1.5 million tests					
Inter-instrume	ΛΕ*ab with	in 0.2(BCRA	color charts	s II average	of the 12	
nt agreement	ΔE*ab within 0.2(BCRA color charts II, average of the 12 charts)					
Size	181*73*112mm(L*W*H)					
Weight	about 550g(does not include battery's weight)					
Display	True color screen that includes all colors					
Work	True color screen that includes all colors					
temperature	0~45℃, relative humidity 80% or below(at 35°C),no					
range	condensation					
Storage						
temperature	-25℃ to 55	℃, relative I	humidity 80%	% or below(a	t 35°C),no	
range	condensation					
	DC adapter	r. Lithium h	attery, man	ual, color m	nanagement	
Standard	DC adapter, Lithium battery, manual, color manageme software, drive software, electronic manual, col					
accessories	accessories management guide, USB cable, black/white calibration tuk				•	
	a.iageinei	94140, 001	- Jabio, biddi	winto camb	. attorr tobo,	

Туре	HSCD-680	HSCD-700	HSCD-710	HSCD-750	HSCI	D-760
	protective cover, spire lamella, portable bag, electronic color					
	charts, measurement and test report					
Optional	powder molding device, micro printer					
Color						
matching	not match	match				
system		60				
	.0.			With UV	with	out
UV light source	without UV light source		light	UV	light	
				source	source	

Application

